

**Notice of References Cited**

Application/Control No.

09/980,909

Applicant(s)/Patent Under  
Reexamination  
ONO ET AL.

Examiner

Jacob K. Ackun Jr.

Art Unit

3712

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,333,570	06-1982	Heider, James E.	206/432
	B	US-4,166,532	09-1979	Tsuchida et al.	206/705
	C	US-4,696,402	09-1987	Harmon et al.	229/120.011
	D	US-4,971,197	11-1990	Worley, Larry W.	206/705
	E	US-6,105,776	08-2000	Meilhon, Daniel	206/497
	F	US-5,667,071	09-1997	Nakagoshi et al.	206/455
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.